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Response Under 37 CFR 1.116  
Expedited Procedure  
Group No. 2829

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: K. ASAYAMA, et al.

Application No.: 10/051,056

Filed: January 22, 2002

For: METHOD FOR MANUFACTURING A SEMICONDUCTOR  
DEVICE TO PROVIDE A PLURALITY OF TEST ELEMENT  
GROUPS (TEGs) IN A SCRIBE REGION (As Amended)

Art Unit: 2829

Examiner: E. T. Pert

*Please enter*  
*EP*  
*9-20-04*

**AMENDMENT AFTER FINAL REJECTION**

Mail Stop AF

September 7, 2004

Commissioner For Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated June 6, 2004, please amend the  
above-identified application as listed below and as set forth on the following pages:

**Amendments to the Claims; and**

**Remarks are included following the amendments.**